

DOUT2

DOUT1

ROUT2

DIN1

RIN1

ROUT1

RIN2

DB, DW, OR NT PACKAGE

(TOP VIEW)

2

3

4

5

6

7

24

22

23

DOUT3

RIN3

ROUT3

21 DIN4

19 DIN3

18 DIN2

20 DOUT4

SLLS810-JULY 2007

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## FEATURES

- ESD Protection for RS-232 I/O Pins ±15-kV Human-Body Model (HBM)
- Meets or Exceeds the Requirements of TIA/EIA-232-F and ITU v.28 Standards
- Operates at 5-V V<sub>CC</sub> Supply
- Four Drivers and Four Receivers •
- Operates up to 120 kbit/s •
- External Capacitors . . .  $4 \times 0.1 \ \mu F$ •
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II

## **APPLICATIONS**

- **Battery-Powered Systems** •
- **PDAs**
- Notebooks
- Laptops •
- Palmtop PCs •
- **Hand-Held Equipment**

## **DESCRIPTION/ORDERING INFORMATION**

17 8 ROUT4 GND | 9 16 RIN4 VCC 10 15 Πν\_ C1+ L 11 14 C2-V+ 12 13 C2+ C1

The TRS208 device consists of four line drivers, four line receivers, and a dual charge-pump circuit with ±15-kV HBM ESD protection pin to pin (serial-port connection pins, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 5-V supply. The devices operate at data signaling rates up to 120 kbit/s and a maximum of 30-V/us driver output slew rate.

### **ORDERING INFORMATION**

T <sub>A</sub>	P	ACKAGE <sup>(1)(2)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING		
	PDIP – NT	Tube of 15	TRS208CNT	PREVIEW		
		Tube of 25	TRS208CDW	TROOMC		
0°C to 70°C	SOIC – DW	Reel of 2000	TRS208CDWR	TRS208C		
	SSOD DD	Tube of 60	TRS208CDB	DI 108C		
	SSOP – DB	Reel of 2000	TRS208CDBR	RU08C		
199. 14	PDIP – NT	Tube of 15	TRS208INT	PREVIEW		
		Tube of 25	TRS208IDW	трезон		
–40°C to 85°C	SOIC – DW	Reel of 2000	TRS208IDWR	- TRS2081		
		Tube of 60	TRS208IDB	RU08I		
	SSOP – DB	Reel of 2000	TRS208IDBR	- RU08I		

Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at (1) www.ti.com/sc/package.

For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI (2)WWW.0ZSC.COM website at www.ti.com.



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### **FUNCTION TABLES**

#### Each Driver<sup>(1)</sup>

INPUT DIN	OUTPUT DOUT
L	Н
н	L

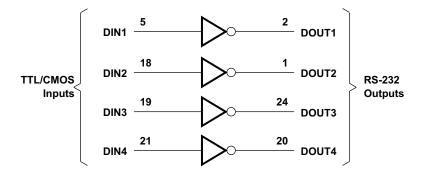
(1) H = high level, L = low level

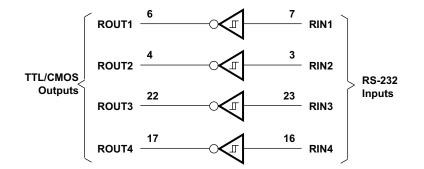
#### Each Receiver<sup>(1)</sup>

INPUT RIN	OUTPUT ROUT
L	Н
н	L
Open	Н

 H = high level, L = low level, Open = input disconnected or connected driver off

#### LOGIC DIAGRAM (POSITIVE LOGIC)





#### Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range <sup>(2)</sup>		-0.3	6	V
V+	Positive charge pump voltage range <sup>(2)</sup>		V <sub>CC</sub> – 0.3	14	V
V–	Negative charge pump voltage range <sup>(2)</sup>		-14	0.3	V
V+ - V-	Supply voltage difference <sup>(2)</sup>			13	V
VI		Drivers	-0.3	V+ + 0.3	V
	Input voltage range	Receivers		±30	V
		Drivers	V0.3	V+ + 0.3	
Vo	Output voltage range	Receivers	-0.3	V <sub>CC</sub> + 0.3	V
	Short-circuit duration	DOUT		Continuous	
		DB package <sup>(3)(4)</sup>		63	
$\theta_{JA}$	Package thermal impedance	DW package <sup>(3)(4)</sup>		46	°C/W
	NT package <sup>(3)(5)</sup>			67	
TJ	Operating virtual junction temperature	·		150	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are with respect to network GND.

(3) Maximum power dissipation is a function of  $T_J(max)$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_J(max) - T_A)/\theta_{JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can affect reliability.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

(5) The package thermal impedance is calculated in accordance with JESD 51-3.

### Recommended Operating Conditions<sup>(1)</sup>

#### See Figure 4

			MIN	NOM	MAX	UNIT
	Supply voltage		4.5	5	5.5	V
VIH	Driver high-level input voltage	DIN	2			V
VIL	Driver low-level input voltage	DIN			0.8	V
V	Driver input voltage DIN		0		5.5	Ň
VI	Receiver input voltage	Receiver input voltage				V
T <sub>A</sub>	Operating free air temperature	TRS208C	0		70	°C
	Operating free-air temperature TRS208I		-40		85	°C

(1) Test conditions are C1–C4 = 0.1  $\mu F$  at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

## Electrical Characteristics<sup>(1)</sup>

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 4)

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
I <sub>CC</sub>	Supply current	No load,	$V_{CC} = 5 V,$	$T_A = 25^{\circ}C$		11	20	mA

(1) Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V.

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## **DRIVER SECTION**

## Electrical Characteristics<sup>(1)</sup>

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 4)

	PARAMETER	TEST CONDIT	IONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	DOUT at $R_L = 3 \text{ k}\Omega$ to GND,	DIN = GND	5	9		V
V <sub>OL</sub>	Low-level output voltage	DOUT at $R_L = 3 \text{ k}\Omega$ to GND,	$DIN = V_{CC}$	-5	-9		V
I <sub>IH</sub>	High-level input current	$V_I = V_{CC}$			15	200	μA
I <sub>IL</sub>	Low-level input current	V <sub>I</sub> at 0 V			-15	-200	μA
$I_{OS}^{(3)}$	Short-circuit output current	V <sub>CC</sub> = 5.5 V,	$V_0 = 0 V$		±10	±60	mA
r <sub>o</sub>	Output resistance	$V_{CC}$ , V+, and V- = 0 V,	$V_0 = \pm 2 V$	300			Ω

(1) Test conditions are C1–C4 = 0.1  $\mu F$  at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

(2) All typical values are at  $V_{CC} = 5$  V, and  $T_A = 25^{\circ}C$ (3) Short-circuit durations should be controlled to prevent exceeding the device absolute power dissipation ratings, and not more than one output should be shorted at a time.

## Switching Characteristics<sup>(1)</sup>

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 4)

	PARAMETER	TEST CO	NDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
	Maximum data rate	$C_L = 50 \text{ pF}$ to 1000 pF, One DOUT switching,	$R_L = 3 k\Omega$ to 7 k $\Omega$ , See Figure 1	120			kbit/s
t <sub>PLH(D)</sub>	Propagation delay time, low- to high-level output	C <sub>L</sub> = 2500 pF, All drivers loaded,	$R_L = 3 k\Omega$ , See Figure 1		2		μs
t <sub>PHL(D)</sub>	Propagation delay time, high- to low-level output	C <sub>L</sub> = 2500 pF, All drivers loaded,	$R_L = 3 k\Omega$ , See Figure 1		2		μs
t <sub>sk(p)</sub>	Pulse skew <sup>(3)</sup>	$C_L = 150 \text{ pF to } 2500 \text{ pF},$ See Figure 2	$R_L = 3 k\Omega$ to 7 k $\Omega$ ,		300		ns
SR(tr)	Slew rate, transition region (see Figure 1)	$C_L = 50 \text{ pF to } 1000 \text{ pF},$ $V_{CC} = 5 \text{ V}$	$R_L = 3 k\Omega$ to 7 k $\Omega$ ,	3	6	30	V/µs

(1) Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V. (2) All typical values are at V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

(3) Pulse skew is defined as  $|t_{PLH} - t_{PHL}|$  of each channel of the same device.

## **ESD** Protection

PIN	TEST CONDITIONS	TYP	UNIT
DOUT, RIN	Human-Body Model (HBM)	±15	kV

## **RECEIVER SECTION**

## Electrical Characteristics<sup>(1)</sup>

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 4)

	PARAMETER	TEST CONDITIONS	;	MIN	TYP	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	$I_{OH} = -1 \text{ mA}$		3.5			V
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 1.6 mA				0.4	V
$V_{IT+}$	Positive-going input threshold voltage	$V_{CC} = 5 \text{ V}, \qquad \qquad T_A = 25^{\circ}\text{C}$			1.7	2.4	V
$V_{IT-}$	Negative-going input threshold voltage	$V_{CC} = 5 \text{ V}, \qquad \qquad T_A = 25^{\circ}\text{C}$		0.8	1.2		V
V <sub>hys</sub>	Input hysteresis (V <sub>IT+</sub> – V <sub>IT–</sub> )	$V_{CC} = 5 V$		0.2	0.5	1	V
r <sub>i</sub>	Input resistance	$V_1 = \pm 3 \text{ V to } \pm 25 \text{ V},  V_{CC} = 5 \text{ V},$	$T_A = 25^{\circ}C$	3	5	7	kΩ

(1) Test conditions are C1–C4 = 0.1  $\mu F$  at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

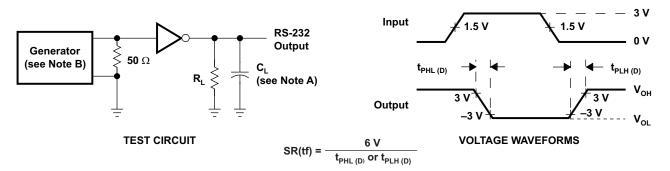
### Switching Characteristics<sup>(1)</sup>

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 3)

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
t <sub>PLH(R)</sub>	Propagation delay time, low- to high-level output	C <sub>L</sub> = 150 pF		0.5	10	μs
t <sub>PHL(R)</sub>	Propagation delay time, high- to low-level output	C <sub>L</sub> = 150 pF		0.5	10	μs
t <sub>sk(p)</sub>	Pulse skew <sup>(3)</sup>			300		ns

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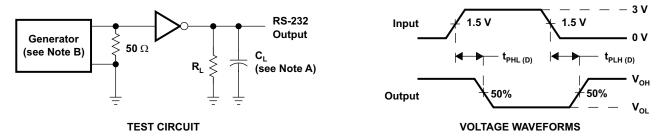
## PARAMETER MEASUREMENT INFORMATION



NOTES: A.  $C_L$  includes probe and jig capacitance.

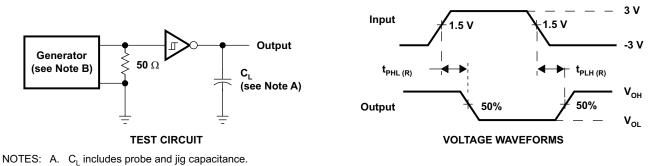
B. The pulse generator has the following characteristics: PRR = 120 kbit/s,  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

#### Figure 1. Driver Slew Rate



NOTES: A. C<sub>L</sub> includes probe and jig capacitance. B. The pulse generator has the following characteristics: PRR = 120 kbit/s,  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

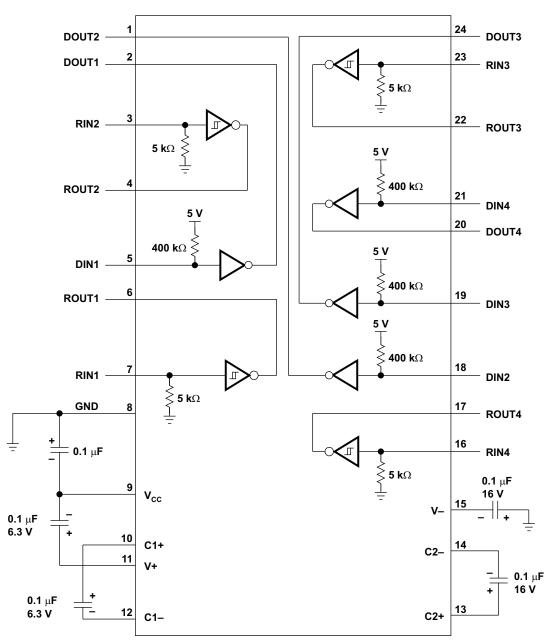
#### Figure 2. Driver Pulse Skew



B. The pulse generator has the following characteristics:  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

#### Figure 3. Receiver Propagation Delay Times

## **APPLICATION INFORMATION**



NOTES: A. Resistor values shown are nominal.

B. Non-polarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

## Figure 4. Typical Operating Circuit and Capacitor Values

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## **APPLICATION INFORMATION (continued)**

#### **Capacitor Selection**

The capacitor type used for C1–C4 is not critical for proper operation. The TRS208 requires 0.1- $\mu$ F capacitors, although capacitors up to 10  $\mu$ F can be used without harm. Ceramic dielectrics are suggested for the 0.1- $\mu$ F capacitors. When using the minimum recommended capacitor values, ensure that the capacitance value does not degrade excessively as the operating temperature varies. If in doubt, use capacitors with a larger (e.g., 2×) nominal value. The capacitors' effective series resistance (ESR), which usually rises at low temperatures, influences the amount of ripple on V+ and V–.

Use larger capacitors (up to 10  $\mu$ F) to reduce the output impedance at V+ and V–.

Bypass  $V_{CC}$  to ground with at least 0.1  $\mu$ F. In applications sensitive to power-supply noise generated by the charge pumps, decouple  $V_{CC}$  to ground with a capacitor the same size as (or larger than) the charge-pump capacitors (C1–C4).

### **Electrostatic Discharge (ESD) Protection**

TI TRS208 devices have standard ESD protection structures incorporated on the pins to protect against electrostatic discharges encountered during assembly and handling. In addition, the RS-232 bus pins (driver outputs and receiver inputs) of these devices have an extra level of ESD protection. Advanced ESD structures were designed to successfully protect these bus pins against ESD discharge of ±15 kV when powered down.

#### **ESD Test Conditions**

ESD testing is stringently performed by TI, based on various conditions and procedures. Please contact TI for a reliability report that documents test setup, methodology, and results.

### Human-Body Model (HBM)

The HBM of ESD testing is shown in Figure 5, while Figure 6 shows the current waveform that is generated during a discharge into a low impedance. The model consists of a 100-pF capacitor, charged to the ESD voltage of concern and subsequently discharged into the DUT through a 1.5-k $\Omega$  resistor.

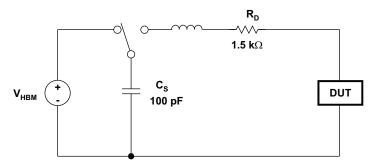


Figure 5. HBM ESD Test Circuit

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## **APPLICATION INFORMATION (continued)**

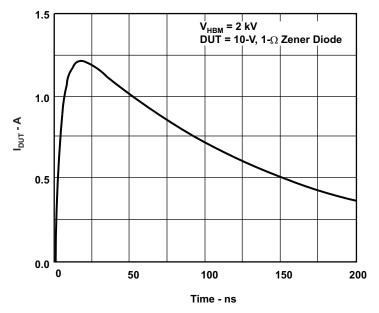


Figure 6. Typical HBM Current Waveform

## Machine Model (MM)

The MM ESD test applies to all pins using a 200-pF capacitor with no discharge resistance. The purpose of the MM test is to simulate possible ESD conditions that can occur during the handling and assembly processes of manufacturing. In this case, ESD protection is required for all pins, not just RS-232 pins. However, after PC board assembly, the MM test no longer is as pertinent to the RS-232 pins.

PACKAG



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#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/ Ball Finish	MSL Pe
TRS208CDB	ACTIVE	SSOP	DB	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208CDBG4	ACTIVE	SSOP	DB	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208CDBR	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208CDBRG4	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208CDWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208CDWRG4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208IDB	ACTIVE	SSOP	DB	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208IDBG4	ACTIVE	SSOP	DB	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208IDBR	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208IDBRG4	ACTIVE	SSOP	DB	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208IDWR	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260
TRS208IDWRG4	ACTIVE	SOIC	DW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www. information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.



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**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for **Pb-Free (RoHS Exempt)**: This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retard in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

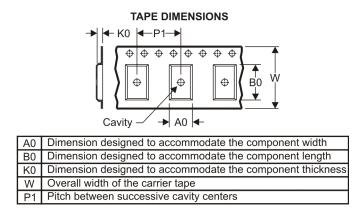
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## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TRS208CDBR	SSOP	DB	24	2000	330.0	16.4	8.2	8.8	2.5	12.0	16.0	Q1
TRS208CDWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
TRS208IDBR	SSOP	DB	24	2000	330.0	16.4	8.2	8.8	2.5	12.0	16.0	Q1
TRS208IDWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1



# PACKAGE MATERIALS INFORMATION

11-Mar-2008

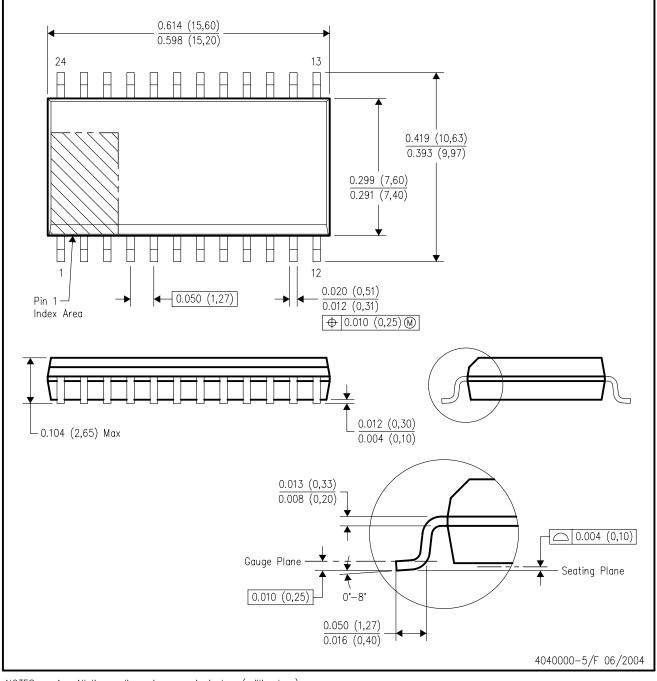


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TRS208CDBR	SSOP	DB	24	2000	346.0	346.0	33.0
TRS208CDWR	SOIC	DW	24	2000	346.0	346.0	41.0
TRS208IDBR	SSOP	DB	24	2000	346.0	346.0	33.0
TRS208IDWR	SOIC	DW	24	2000	346.0	346.0	41.0

DW (R-PDSO-G24)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



# **MECHANICAL DATA**

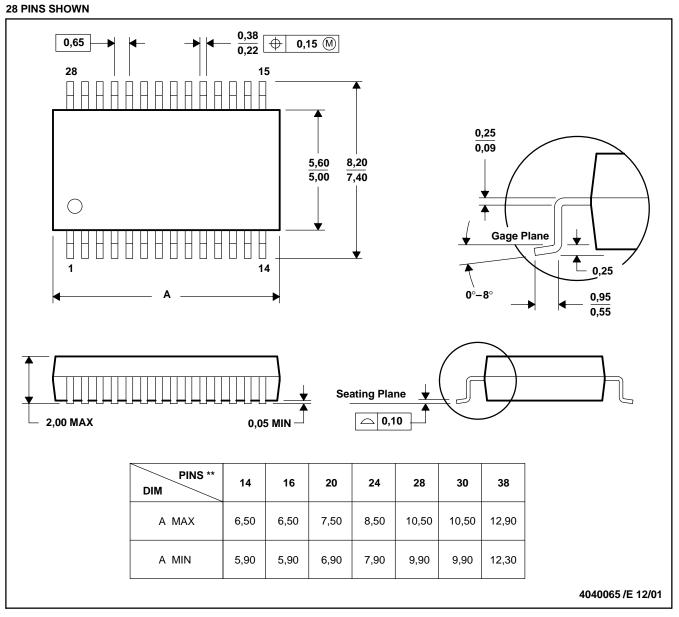
MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

# DB (R-PDSO-G\*\*)

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PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



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